Notice of References Cited Application/Control No. 10/535,292 Examiner David H. Chu Applicant(s)/Patent Under Reexamination WEESE ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,038,302 A	08-1991	Kaufman, Arie E.	345/424
*	В	US-5,381,518 A	01-1995	Drebin et al.	345/424
*	С	US-6,055,330 A	04-2000	Eleftheriadis et al.	382/154
*	D	US-6,091,777 A	07-2000	Guetz et al.	375/240.11
*	E	US-6,084,908 A	07-2000	Chiang et al.	375/240.03
*	F	US-6,157,677 A	12-2000	Martens et al.	375/240.16
*	G	US-6,205,350 B1	03-2001	Lorenz et al.	600/425
*	Н	US-2001/0048731 A1	12-2001	Nakamura et al.	378/4
*	ı	US-2002/0045153 A1	04-2002	Kaufman et al.	434/262
*	J	US-6,450,962 B1	09-2002	Brandl et al.	600/458
*	κ	US-2004/0075658 A1	04-2004	Goto, Yoshihiro	345/426
*	L	US-2005/0169507 A1	08-2005	Kreeger et al.	382/128
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
<u>.</u>	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.